Unit: mm

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSV)

2SK2679

Chopper Regulator, DC-DC Converter and Motor Drive Applications

• Low drain–source ON resistance : RDS (ON) = 0.84 Ω (typ.)

• High forward transfer admittance : $|Y_{fs}| = 4.4 \text{ S (typ.)}$

• Low leakage current : $I_{DSS} = 100 \mu A \text{ (max) (V}_{DS} = 400 \text{ V)}$

• Enhancementmode : $V_{th} = 2.0 \sim 4.0 \text{ V (Vps} = 10 \text{ V, Ip} = 1 \text{ mA})$

Absolute Maximum Ratings (Ta = 25°C)

Characteris	stics	Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	400	V	
Drain-gate voltage (R _{GS} = 20 kΩ)		V_{DGR}	400	V	
Gate-source voltage		V _{GSS}	±30	V	
Drain current	DC (Note 1)	I _D	5.5	Α	
	Pulse (Note 1)	I _{DP}	22	A	
Drain power dissipation	n (Tc = 25°C)	P _D	35	W	
Single pulse avalanche	e energy (Note 2)	E _{AS}	223	mJ	
Avalanche current		I _{AR}	5.5	A	
Repetitive avalanche e	nergy (Note 3)	E _{AR}	3.5	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	

Weight: 1.9 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	3.57	°C/W
Thermal resistance, channel to ambient	R _{th (ch-a)}	62.5	°C / W

Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: $V_{DD} = 90 \text{ V}$, $T_{ch} = 25^{\circ}\text{C}$ (initial), L = 12 mH, $R_G = 25 \Omega$, $I_{AR} = 5.5 \text{ A}$

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device.

Please handle with caution.



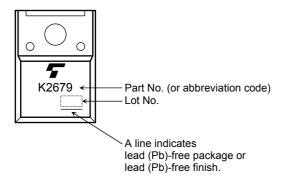
Electrical Characteristics (Ta = 25°C)

Charac	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	irrent	I _{GSS}	V _{GS} = ±25 V, V _{DS} = 0 V	_	_	±10	μΑ
Gate-source bre	eakdown voltage	V _(BR) GSS	$I_G = \pm 10 \ \mu A, \ V_{DS} = 0 \ V$	±30	_	_	V
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = 400 V, V _{GS} = 0 V	_	_	100	μΑ
Drain-source br	eakdown voltage	V _{(BR) DSS}	I _D = 10 mA, V _{GS} = 0 V	400	_	_	V
Gate threshold v	oltage/	V_{th}	V _{DS} = 10 V, I _D = 1 mA	2.0	_	4.0	V
Drain-source O	N resistance	R _{DS} (ON)	V _{GS} = 10 V, I _D = 3 A	_	0.84	1.2	Ω
Forward transfer	r admittance	Y _{fs}	V _{DS} = 10 V, I _D = 3 A	2.0	4.4	_	S
Input capacitano	e	C _{iss}		_	720	_	
Reverse transfe	r capacitance	C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	_	80	_	pF
Output capacitance		C _{oss}		_	250	_	
Switching time	Rise time	t _r	V_{GS} V_{OV} V_{OU} V_{OU} V_{DD} V_{OU}	_	15	_	
	Turn-on time	t _{on}		_	30	_	ne
	Fall time	t _f		. –	25	_	ns
	Turn-off time	t _{off}	Duty $\leq 1\%$, $t_W = 10 \mu s$	0	110	_	
Total gate charg plus gate-drain)		Qg	Com		17		
Gate-source charge		Q _{gs}	$V_{DD} \approx 320 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 5.5 \text{ A}$	_	10		nC
Gate-drain ("miller") Charge		Q _{gd}		_	7		

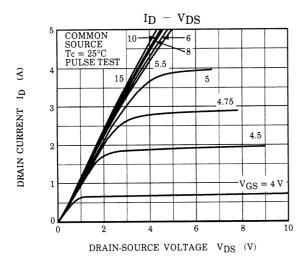
Source-Drain Ratings and Characteristics (Ta = 25°C)

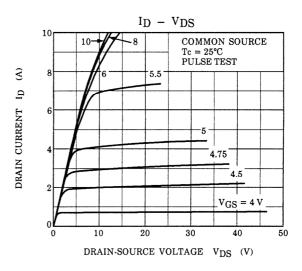
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	_	_	5.5	Α
Pulse drain reverse current (Note 1)	I _{DRP}	_	_	_	22	Α
Forward voltage (diode)	V _{DSF}	I _{DR} = 5.5 A, V _{GS} = 0 V	_	_	-1.7	V
Reverse recovery time	t _{rr}	I _{DR} = 5.5 A, V _{GS} = 0 V	1	350	_	ns
Reverse recovery charge	Q _{rr}	dl _{DR} / dt = 100 Å / μs		2.1	_	μC

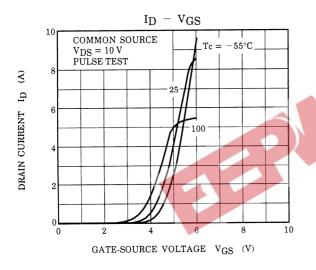
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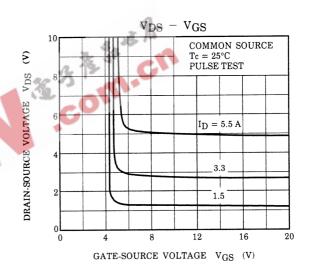


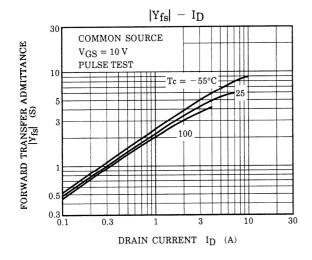
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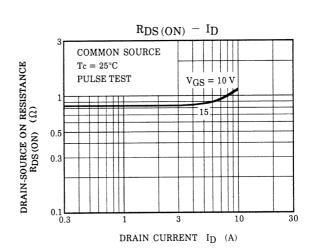




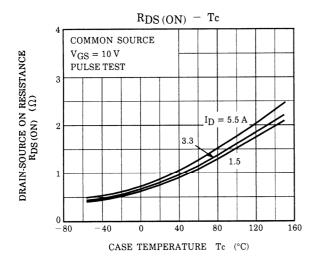


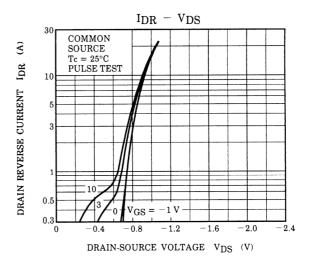


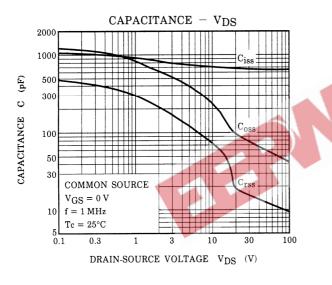


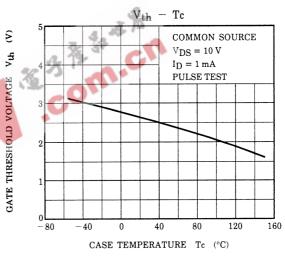


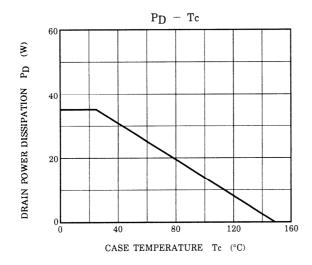
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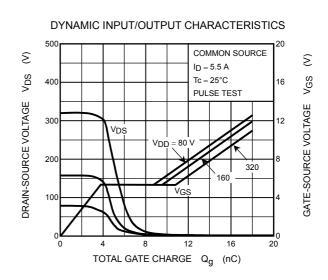


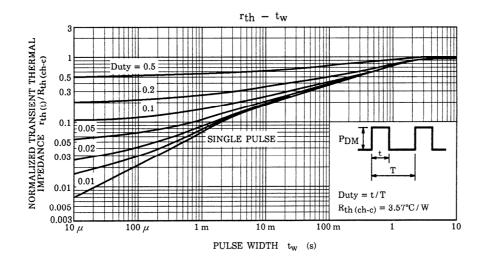


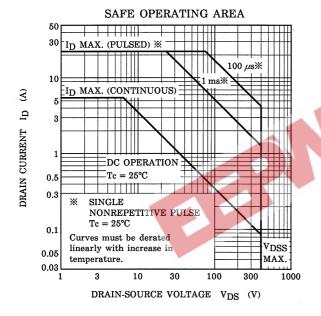


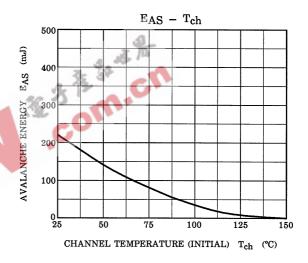


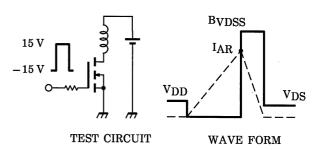












$$\begin{aligned} &RG = 25 \ \Omega \\ &V_{DD} = 90 \ V, \ L = 12 \ mH \end{aligned} \qquad EAS = \frac{1}{2} \cdot L \cdot I^2 \cdot \left(\frac{BVDSS}{BVDSS - V_{DD}} \right)$$

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